Application/Control No.	Applicant(s)/Patent under Reexamination	
10/645,807	LIN ET AL.	
Examiner	Art Unit	
Tuan H. Nguyen	2618	

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	67.11,69	9/15/2006	T.N
455	452.2	9/15/2006	T.N
455	522	9/15/2006	T.N
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INI	NTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
All searches are on EAST data base.	9/15/2006	T.N		
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